App. Serial No. 10/530,063 Docket No.: BE 020027 US

## In the Claims:

Please amend claims 7, 8 and 17-20 as indicated below. This listing of claims replaces all prior versions.

- 1. (Original) A method of manufacturing a semiconductor device comprising the step of depositing an epitaxial layer based on Group IV elements on a silicon substrate by Chemical Vapor Deposition, and including employing nitrogen or a noble gas as a carrier gas.
- 2. (Previously presented) A method as claimed in claim 1, the method forming an epitaxial layer based on at least one of the following: silicon, germanium, and carbon.
- 3. (Original) A method as claimed in claim 2, wherein the epitaxial layer comprises Si<sub>1-y</sub>C<sub>y</sub>.
- 4. (Original) A method as claimed in claim 2, wherein the epitaxial layer comprises a SiGe epitaxial layer.
- 5. (Original) A method as claimed in claim 2, wherein the epitaxial layer comprises Si<sub>1-x-y</sub>Ge<sub>x</sub>C<sub>y</sub>.
- 6. (Original) A method as claimed in claim 2, wherein the epitaxial layer comprises a silicon epitaxial layer.
- 7. (Currently amended) A method as claimed in claim 2, which is carried out at a [low] temperature that facilitates a CVD growth rate of an epitaxial layer that is substantially greater than a CVD growth rate of such an epitaxial layer using hydrogen as a carrier gas.
- 8. (Currently amended) A method as claimed in claim [7] 2, which is carried out at a temperature of less than about 600°C.

Claims 9-16 (Cancelled).

Sent By: Crawford PLLC;

App. Serial No. 10/530,063 Docket No.: BE 020027 US

- 17. (Currently amended) A method as claimed in claim 3, which is carried out at a [low] temperature of less than about 600°C.
- 18. (Currently amended) A method as claimed in claim 4, which is carried out at a [low] temperature of less than about 600°C.
- 19. (Currently amended) A method as claimed in claim 5, which is carried out at a [low] temperature of less than about 600°C.
- 20. (Currently amended) A method as claimed in claim 6, which is carried out at a [low] temperature of less than about 600°C.